

Notice of References Cited

Application/Control No.

09/924,856

Applicant(s)/Patent Under
Reexamination
HAMPEL ET AL.

Examiner

TRONG PHAN

Art Unit

2818

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,703,830	12-1997	Yasuhiro, Takai	365/233
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	P					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,680,354	10-1997	Kawagoe, Tomoya	365/200
	B	US-5,881,019	03-1999	Koshikawa, Yasuji	365/233
	C	US-5,295,188	03-1994	Wilson et al.	380/30
	D	US-4,071,889	01-1978	Sumida et al.	713/400
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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